


<b>Search Notes</b>  	<b>Application/Control No.</b>  10696096	<b>Applicant(s)/Patent Under Reexamination</b>  WILCOCK ET AL.
	<b>Examiner</b>  Chen, Wenpeng	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	225	9/24/07	/wpc/
348	143	9/24/07	/wpc/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR, FPRS) - See search history printout.	9/22,24,28,30/07	/wpc/
IEEE Xplore - See search condition and result printout.	9/30/07	/wpc/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner